

BTA440Z-800BT

Rev.02 - 28 May 2019

Product data sheet

1. General description

Planar passivated high commutation three quadrant triac in a IITO3P package intended for use in circuits where high static and dynamic dV/dt and high dl/dt can occur. This "series BT" triac will commutate the full RMS current at the maximum rated junction temperature ($T_{i(max)}$ = 150 °C) without the aid of a snubber. It is used in applications where "high junction operating temperature capability" is required.

2. Features and benefits

- **High current TRIAC**
- 3Q technology for improved noise immunity
- High commutation capability with maximum false trigger immunity
- High immunity to false turn-on by dV/dt
- High junction operating temperature capability (T_{i(max)} = 150 °C)
- High voltage capability
- Least sensitive gate for highest noise immunity
- Low thermal resistance
- Planar passivated for voltage ruggedness and reliability
- Triggering in three quadrants only
- Insulated tab rated at 2500Vrms

3. Applications

- Applications subject to high temperature (T_{i(max)} = 150 °C)
- High current / high surge applications
- High power / industrial controls e.g. heating, motors, lighting

4. Quick reference data

| Mi | n Typ | Max | Unit |
|-------------------------------|-------|-----|------|
| - | - | 800 | V |
| C; - | - | 40 | A |
| - C; t _p = 20 ms; | - | 400 | A |
| C; t _p = 16.7 ms - | - | 440 | А |
| - | - | 150 | °C |
| | | | 150 |

3Q Hi-Com Triac

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|-----------------------|---------------------------------------|---|------|-----|-----|------|
| I _{GT} | gate trigger current | $V_D = 12 \text{ V}; \text{ I}_T = 0.1 \text{ A}; \text{ T2+ G+};$ T _j = 25 °C; Fig. 7 | - | - | 50 | mA |
| | | $V_{D} = 12 \text{ V}; \text{ I}_{T} = 0.1 \text{ A}; \text{ T2+ G-};$ T _j = 25 °C; Fig. 7 | - | - | 50 | mA |
| | | $V_{D} = 12 \text{ V}; \text{ I}_{T} = 0.1 \text{ A}; \text{ T2- G-};$ T _j = 25 °C; Fig. 7 | - | - | 50 | mA |
| I _H | holding current | V _D = 12 V; T _j = 25 °C; <u>Fig. 9</u> | - | - | 80 | mA |
| V _T | on-state voltage | I _T = 56.6 A; T _j = 25 °C; <u>Fig. 10</u> | - | - | 1.5 | V |
| Dynamic o | characteristics | | | | | |
| dV _D /dt | rate of rise of off-state voltage | V_{DM} = 536 V; T _j = 150 °C; (V _{DM} = 67% of V _{DRM}); exponential waveform; gate open circuit | 1000 | - | - | V/µs |
| dl _{com} /dt | rate of change of commutating current | $V_D = 400 \text{ V}; \text{ T}_j = 150 \text{ °C}; \text{ I}_{T(RMS)} = 20 \text{ A};$ $dV_{com}/dt = 20 \text{ V}/\mu\text{s}; \text{ (snubberless condition); gate open circuit}$ | 15 | - | - | A/ms |

5. Pinning information

| Table 2. | Pinning infor | mation | | |
|----------|----------------------|-------------------------|--------------------|----------------|
| Pin | Symbol | Description | Simplified outline | Graphic symbol |
| 1 | T1 | main terminal 1 | \bigcirc | N |
| 2 | T2 | main terminal 2 | 0 | |
| 3 | G | gate | | sym051 |
| mb | n.c. | mounting base; isolated | | |
| | | | IITO3P (SOT1292) | |

6. Ordering information

| Table 3. Ordering information | | | | | | | | |
|-------------------------------|---------|-----------------------|---------|---------------|---------|--------------|--|--|
| Type number | Package | Orderable part number | Packing | Small packing | Package | Package | | |
| | Name | | method | quantity | version | issue date | | |
| BTA440Z-800BT | IITO3P | BTA440Z-800BTQ | Tube | 30 | SOT1292 | 21-July-2017 | | |

7. Marking

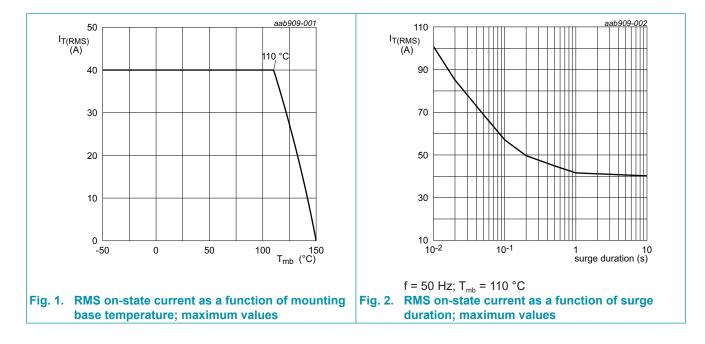
| Table 4. Marking codes | |
|------------------------|---------------|
| Type number | Marking code |
| BTA440Z-800BT | BTA440Z-800BT |

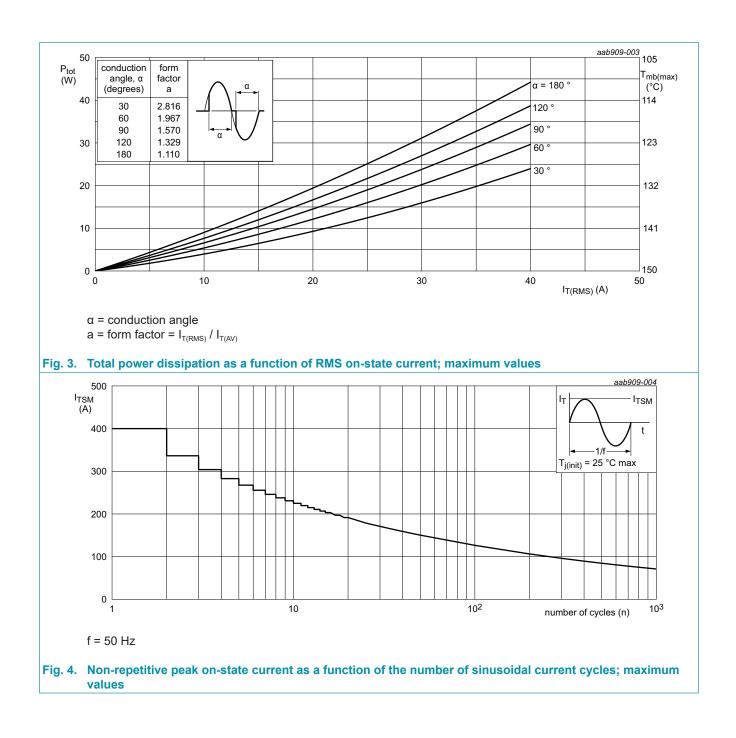
8. Limiting values

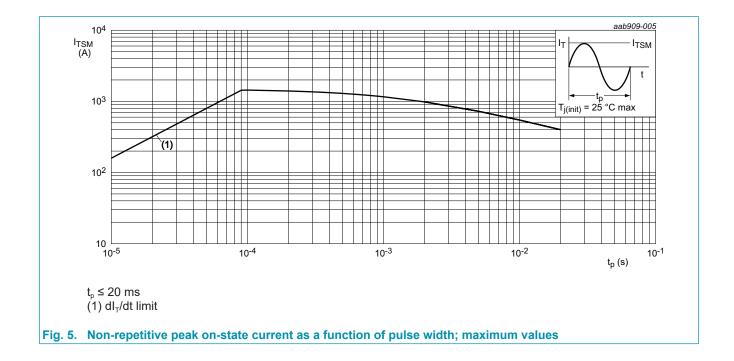
Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol | Parameter | Conditions | Min | Max | Unit |
|---|--|--|-----|-----|------------------|
| V_{DRM} | repetitive peak off-state voltage | | - | 800 | V |
| $\mathbf{I}_{\mathrm{T}(\mathrm{RMS})}$ | RMS on-state current | full sine wave; T _{mb} ≤ 110 °C; <u>Fig. 1; Fig. 2; Fig. 3</u> | - | 40 | A |
| I _{TSM} | non-repetitive peak on- state current | full sine wave; T _{j(init)} = 25 °C; t _p = 20 ms; <u>Fig 4; Fig 5</u> | - | 400 | A |
| | | full sine wave; $T_{j(init)}$ = 25 °C; t_p = 16.7 ms | - | 440 | А |
| l ² t | l ² t for fusing | t_p = 10 ms; sine-wave pulse | - | 800 | A ² s |
| dl _⊤ /dt | rate of rise of on-state current | I _G = 100 mA | - | 150 | A/µs |
| I _{GM} | peak gate current | t _p = 20 μs | - | 8 | А |
| P_{GM} | peak gate power | t _p = 20 μs | - | 40 | W |
| $P_{\text{G}(\text{AV})}$ | average gate power | | - | 1 | W |
| T _{stg} | storage temperature | | -40 | 150 | °C |
| Tj | junction temperature | | - | 150 | °C |







9. Thermal characteristics

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|----------------------|--|-------------|-----|-----|-----|------|
| $R_{th(j-mb)}$ | thermal resistance from junction to mounting base | Fig 6 | - | - | 0.9 | K/W |
| $R_{\text{th(j-a)}}$ | thermal resistance from junction to ambient free air | in free air | - | 50 | - | K/W |

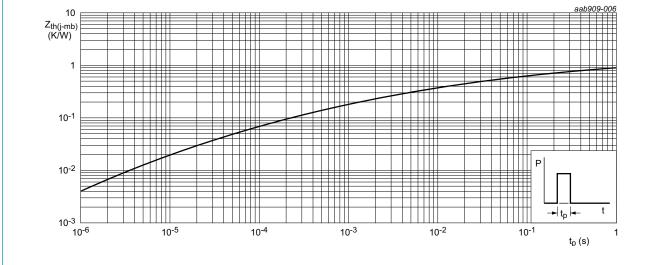


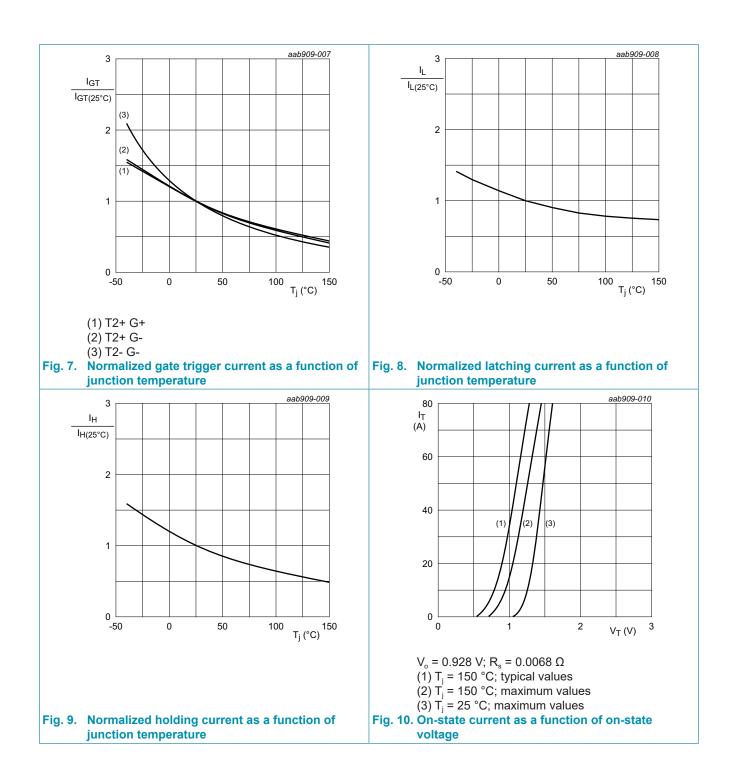
Fig. 6. Transient thermal impedance from junction to mounting base as a function of pulse duration

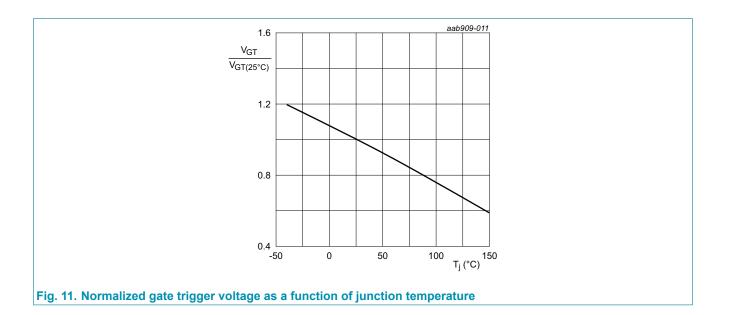
10. Isolation Characteristics

| Table 7. Iso | olation Characteristics | | | | | |
|------------------------|-------------------------|--|-----|-----|------|------|
| Symbol | Parameter | Conditions | Min | Тур | Мах | Unit |
| V _{isol(RMS)} | RMS isolation voltage | from all terminals to external heatsink; sinusoidal waveform; clean and dust free; 50 Hz \leq f \leq 60 Hz; RH \leq 65 %; T _{mb} = 25 °C | - | - | 2500 | V |

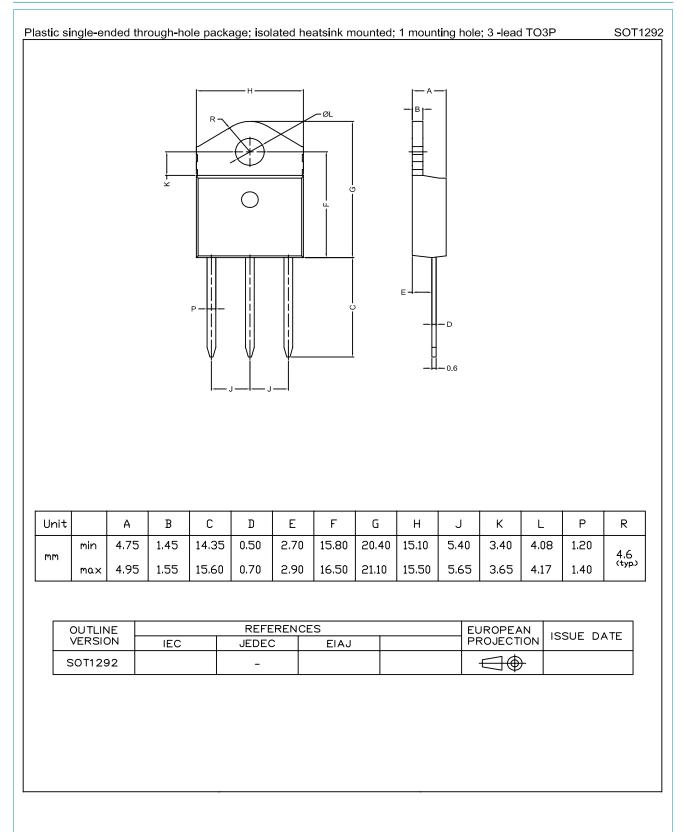
11. Characteristics

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|---------------------------------|---------------------------------------|--|---|------|-----|------|
| Static cha | aracteristics | | | | | |
| I _{GT} | gate trigger current | $V_{D} = 12 \text{ V}; \text{ I}_{T} = 0.1 \text{ A}; \text{ T2+ G+};$ T _j = 25 °C; Fig. 7 | - | - | 50 | mA |
| | | $V_{D} = 12 \text{ V}; \text{ I}_{T} = 0.1 \text{ A}; \text{ T2+ G-};$ T _j = 25 °C; Fig. 7 | - | - | 50 | mA |
| | | $V_{\rm D}$ = 12 V; I _T = 0.1 A; T2- G-; T _j = 25 °C; Fig. 7 | - | - | 50 | mA |
| I _L latching current | latching current | $V_{D} = 12 \text{ V}; \text{ I}_{G} = 0.1 \text{ A}; \text{ T2+ G+};$ T _j = 25 °C; <u>Fig. 8</u> | - | - | 85 | mA |
| | | $V_{D} = 12 \text{ V}; \text{ I}_{G} = 0.1 \text{ A}; \text{ T2+ G-};$ T _j = 25 °C; <u>Fig. 8</u> | - | - | 160 | mA |
| | | | V _D = 12 V; I _G = 0.1 A; T2- G-; T _j = 25 °C; <u>Fig. 8</u> | - | - | 85 |
| I _H | holding current | V _D = 12 V; T _j = 25 °C; <u>Fig. 9</u> | - | - | 80 | mA |
| V _T | on-state voltage | I _T = 56.6 A; T _j = 25 °C; <u>Fig. 10</u> | - | - | 1.5 | V |
| V _{GT} | gate trigger voltage | V _D = 12 V; T _j = 25 °C; <u>Fig. 11</u> | - | 0.8 | 1.3 | V |
| | | V _D = 400 V; T _j = 150 °C | 0.2 | 0.45 | - | V |
| I _D | off-state current | V _D = 800 V; T _j = 25 °C | - | - | 10 | μA |
| | | V _D = 800 V; T _j = 150 °C | - | - | 2 | mA |
| Dynamic | characteristics | | | 1 | | |
| dV _D /dt | rate of rise of off-state voltage | V_{DM} = 536 V; T _j = 150 °C; (V _{DM} = 67% of V _{DRM}); exponential waveform; gate open circuit | 1000 | - | - | V/µs |
| dl _{com} /dt | rate of change of commutating current | $V_D = 400 \text{ V}; \text{ T}_j = 150 \text{ °C}; \text{ I}_{T(RMS)} = 20 \text{ A};$ $dV_{com}/dt = 20 \text{ V}/\mu \text{s}; \text{ (snubberless condition); gate open circuit}$ | 15 | - | - | A/ms |





12. Package outline



13. Legal information

Data sheet status

| Document status [1][2] | Product status [3] | Definition |
|--------------------------------------|-----------------------|---|
| Objective [short] data sheet | Development | This document contains data from the objective specification for product development. |
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